Application/Control No. Applicant(s)/Patent Under Reexamination 10/082,794 BAU ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2192 J. Derek Rutten **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY * US-2003/0014733 A1 01-2003 Ringseth et al. 717/116 Α US-2005/0021594 A1 01-2005 Bernardin et al. В 709/200 * US-6,427,234 B1 07-2002 С Chambers et al. 717/140 US-D US-Ε US-F US-G US-Н US-US-J USκ US-

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